

# FDS4410A Single N-Channel, Logic-Level, PowerTrench® MOSFET

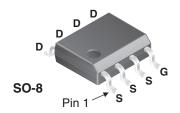
### **Features**

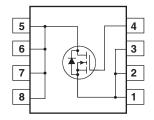
- 10 A, 30 V.  $R_{DS(ON)} = 13.5 \text{ m}\Omega$  @  $V_{GS} = 10 \text{ V}$  $R_{DS(ON)} = 20 \text{ m}\Omega$  @  $V_{GS} = 4.5 \text{ V}$
- Fast switching speed
- Low gate charge
- $\blacksquare$  High performance trench technology for extremely low  $R_{DS(ON)}$
- High power and current handling capability

### **General Description**

This N-Channel Logic Level MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.





## Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter	Ratings	Units	
V <sub>DSS</sub>	Drain-Source Voltage		30	V
V <sub>GSS</sub>	Gate-Source Voltage		±20	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	10	А
	– Pulsed		50	
P <sub>D</sub>	Power Dissipation for Single Operation	(Note 1a)	2.5	W
		(Note 1b)	1.0	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C
Thermal Cha	racteristics			•
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W
		(Note 1b)	125	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	25	

### **Package Marking and Ordering Information**

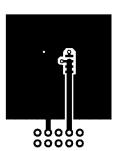
<b>Device Marking</b>	Device	Reel Size	Tape width	Quantity	
FDS4410A	FDS4410A	13"	12mm	2500 units	l

# **Electrical Characteristics** $T_A = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Charac	cteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25°C		25		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V			1	μА
		V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55°C			10	
I <sub>GSS</sub>	Gate-Body Leakage	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA
On Charac	cteristics (Note 2)			•		•
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1	1.9	3	V
$\frac{\Delta V_{\text{GS(th)}}}{\Delta T_{J}}$	Gate Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C		-5		mV/°C
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 9 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}, T_J = 125^{\circ}\text{C}$		9.8 12.0 13.7	13.5 20 23	mΩ
I <sub>D(on)</sub>	On-State Drain Current	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 5 V	50			Α
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 10 A		48		S
Dynamic C	Characteristics				'	
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz		1205		pF
C <sub>oss</sub>	Output Capacitance	1		290		pF
C <sub>rss</sub>	Reverse Transfer Capacitance	]		115		pF
R <sub>G</sub>	Gate Resistance	V <sub>GS</sub> = 15 mV, f = 1.0 MHz		2.4		Ω
Switching	Characteristics (Note 2)			'		•
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 1 A, V <sub>GS</sub> = 10 V,		9	19	ns
t <sub>r</sub>	Turn-On Rise Time	$R_{GEN} = 6 \Omega$		5	10	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	_		28	44	ns
t <sub>f</sub>	Turn-Off Fall Time	_		9	19	ns
Qg	Total Gate Charge	V <sub>DD</sub> = 15 V, I <sub>D</sub> = 10 A, V <sub>GS</sub> = 5 V		12	16	nC
Q <sub>gs</sub>	Gate-Source Charge	]		3.4		nC
Q <sub>gd</sub>	Gate-Drain Charge	_		4.0		nC
	rce Diode Characteristics and Maximi	um Ratings		1	1	1
I <sub>S</sub>	Maximum Continuous Drain-Source Di	ode Forward Current			2.1	А
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 2.1 \text{ A}$ (Note 2)		0.74	1.2	V
t <sub>rr</sub>	Diode Reverse Recovery Time	$I_F = 10A$ , $d_{iF}/d_t = 100 A/\mu s$		24		nS
Q <sub>rr</sub>	Diode Reverse Recovery Charge	]		27		nC

#### Notes

1. R<sub>BJA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>BJC</sub> is guaranteed by design while R<sub>BCA</sub> is determined by the user's board design.



a) 50°C/W when mounted on a 1 in² pad of 2 oz copper



b) 125°C/W when mounted on a minimum pad.

Scale 1:1 on letter size paper

2. Test: Pulse Width < 300 $\mu$ s, Duty Cycle < 2.0%

## **Typical Characteristics**

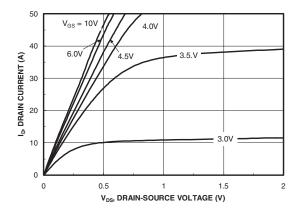


Figure 1. On-Region Characteristics.

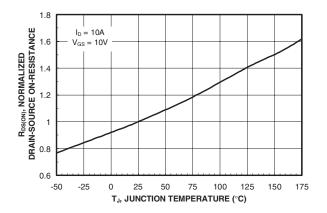


Figure 3. On-Resistance Variation with Temperature.

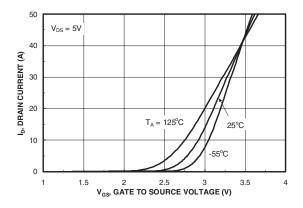


Figure 5. Transfer Characteristics.

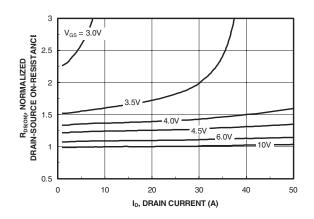


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

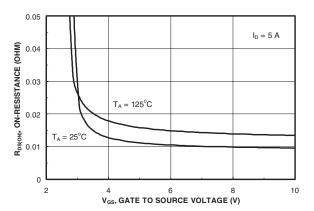


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

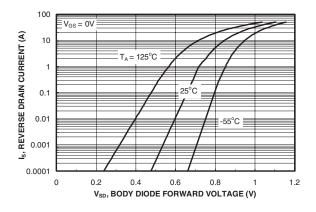
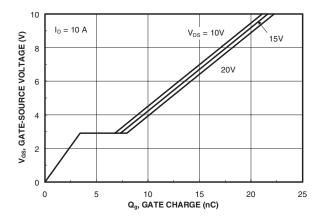


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

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### **Typical Characteristics**



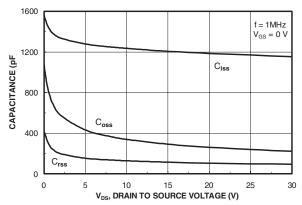
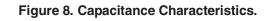
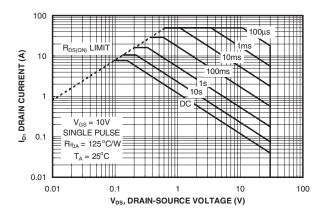


Figure 7. Gate Charge Characteristics.





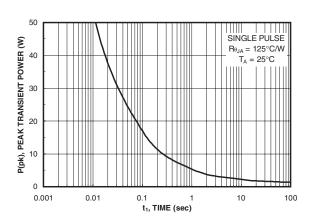


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

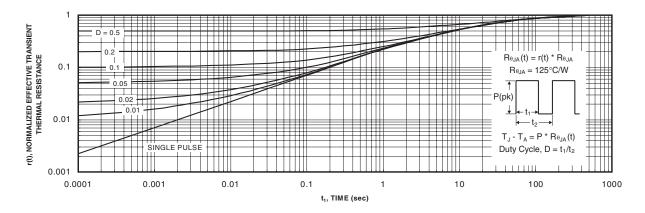


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

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